

N-Channel 80 V (D-S) MOSFET



| PRODUCT SUMMARY | | | | |
|--|--------|--|--|--|
| V _{DS} (V) | 80 | | | |
| $R_{DS(on)}$ max. (Ω) at $V_{GS} = 10 \text{ V}$ | 0.0034 | | | |
| $R_{DS(on)}$ max. (Ω) at $V_{GS} = 7.5 \text{ V}$ | 0.0039 | | | |
| Q _g typ. (nC) | 33.5 | | | |
| I _D (A) | 116 | | | |
| Configuration | Single | | | |

FEATURES

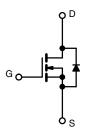
- TrenchFET® Gen V power MOSFET
- Very low R_{DS} x Q_g figure-of-merit (FOM)
- Tuned for the lowest R_{DS} x Q_{oss} FOM
- 100 % R_a and UIS tested
- · Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



HALOGEN **FREE**

APPLICATIONS

- Synchronous rectification
- · Primary side switch
- DC/DC converters
- · OR-ing and hot swap switch
- Power supplies
- · Motor drive control
- · Battery management



N-Channel MOSFET

| ORDERING INFORMATION | |
|----------------------------------|-----------------|
| Package | PowerPAK SO-8 |
| Lead (Pb)-free and halogen-free | SIR582DP-T1-RE3 |
| Alternate manufacturing location | SIR582DP-T1-BE3 |

| ABSOLUTE MAXIMUM RATING | iS (Γ _A = 25 °C, ι | inless otherv | vise noted) | |
|--|--------------------------------------|-----------------------------------|----------------------|------|
| PARAMETER | | SYMBOL | LIMIT | UNIT |
| Drain-source voltage | | V_{DS} | 80 | V |
| Gate-source voltage | | V_{GS} | ± 20 | V |
| | T _C = 25 °C | | 116 | |
| Continuous dusin surrent (T. 150 °C) | T _C = 70 °C | 7 , I | 93 | |
| Continuous drain current (T _J = 150 °C) | T _A = 25 °C | l _D | 28.9 b, c | |
| | T _A = 70 °C | 7 | 23.1 ^{b, c} | ^ |
| Pulsed drain current (t = 100 μs) | | I _{DM} | 300 | A |
| Continuous source-drain diode current | T _C = 25 °C | | 84.1 ^a | |
| | T _A = 25 °C | l _S | 5.1 ^{b, c} | |
| Single pulse avalanche current | l 0.1 mll | I _{AS} | 40 | |
| Single pulse avalanche energy | | | 80 | mJ |
| Maximum power dissipation | T _C = 25 °C | | 92.5 | |
| | T _C = 70 °C | 7 5 1 | 59.2 | 14/ |
| | T _A = 25 °C | P _D | 5.6 b, c | W |
| | T _A = 70 °C | | 3.6 b, c | |
| Operating junction and storage temperature range | | T _J , T _{stg} | -55 to +150 | °C |
| Soldering recommendations (peak temperature) c | | | 260 | |

| THERMAL RESISTANCE RATINGS | | | | | | | |
|--|--------------|-------------------|---------|---------|------|--|--|
| PARAMETER | | SYMBOL | TYPICAL | MAXIMUM | UNIT | | |
| Maximum junction-to-ambient ^b | t ≤ 10 s | R _{thJA} | 18 | 22 | °C/W | | |
| Maximum junction-to-case (drain) | Steady state | R _{thJC} | 1.1 | 1.35 | C/VV | | |

- a. Package limited
- b. Surface mounted on 1" x 1" FR4 board
- c. t = 10 s
- d. See solder profile (www.vishay.com/doc?73257). The PowerPAK SO-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection
- Rework conditions: manual soldering with a soldering iron is not recommended for leadless components
- Maximum under steady state conditions is 62.5 °C/W
- g. $T_C = 25$ °C



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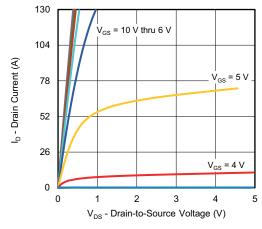
| SPECIFICATIONS ($T_J = 25 ^{\circ}C$, PARAMETER | SYMBOL | TEST CONDITIONS | MIN. | TYP. | MAX. | UNIT | |
|---|--------------------------------------|--|---------|----------|----------|--------|--|
| Static | STIMBOL | TEST CONDITIONS | IVIIIV. | ITF. | WAA. | UNIT | |
| Drain-source breakdown voltage | V _{DS} | V _{GS} = 0 V, I _D = 1 mA | 80 | | T _ | V | |
| V _{DS} temperature coefficient | $\Delta V_{DS}/T_{J}$ | $I_D = 10 \text{ mA}$ | - | 52 | - | V | |
| V _{GS(th)} temperature coefficient | | | | -6.3 | _ | mV/°C | |
| . , | ΔV _{GS(th)} /T _J | I _D = 250 μA | - | -0.3 | 4 | V | |
| Gate-source threshold voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$ | 2 | - | 100 | • | |
| Gate-source leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ | - | - | | nA | |
| Zero gate voltage drain current | I _{DSS} | V _{DS} = 64 V, V _{GS} = 0 V | - | - | 1 | μA | |
| | | V _{DS} = 64 V, V _{GS} = 0 V, T _J = 70 °C | - | - | 15 | | |
| Drain-source on-state resistance a | R _{DS(on)} | $V_{GS} = 10 \text{ V}, I_D = 15 \text{ A}$ | - | 0.0028 | 0.0034 | Ω | |
| | - 5(3.1) | $V_{GS} = 7.5 \text{ V}, I_D = 10 \text{ A}$ | - | 0.0032 | 0.0039 | | |
| Forward transconductance a | 9 _{fs} | $V_{DS} = 15 \text{ V}, I_D = 15 \text{ A}$ | - | 42 | - | S | |
| Dynamic ^b | T | | T | T | | 1 | |
| Input capacitance | C _{iss} | | - | 3360 | - | pF | |
| Output capacitance | C _{oss} | $V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ | - | 1020 | - | | |
| Reverse transfer capacitance | C _{rss} | | - | 9.5 | - | | |
| Total gate charge | Q _g | $V_{DS} = 40 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$ | - | 44.5 | 67 | nC | |
| Total gate charge | Q g | | - | 33.5 | 51 | | |
| Gate-source charge | Q_{gs} | $V_{DS} = 40 \text{ V}, V_{GS} = 7.5 \text{ V}, I_D = 10 \text{ A}$ | - | 16.3 | - | | |
| Gate-drain charge | Q_{gd} | | - | 4.5 | - | | |
| Output charge | Q _{oss} | $V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$ | - | 104 | - | | |
| Gate resistance | R_{g} | f = 1 MHz | 0.4 | 1.1 | 1.9 | Ω | |
| Turn-on delay time | t _{d(on)} | | - | 18 | 36 | | |
| Rise time | t _r | $V_{DD} = 40 \text{ V}, R_L = 4 \Omega, I_D \cong 10 \text{ A},$ | - | 10 | 20 | | |
| Turn-off delay time | t _{d(off)} | $V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$ | - | 28 | 56 | | |
| Fall time | t _f | | - | 12 | 24 | | |
| Turn-on delay time | t _{d(on)} | | - | 21 | 42 | ns | |
| Rise time | t _r | $V_{DD} = 40 \text{ V}, R_L = 4 \Omega, I_D \cong 10 \text{ A},$ | - | 18 | 36 | = = | |
| Turn-off delay time | t _{d(off)} | $V_{GEN} = 7.5 \text{ V}, R_g = 1 \Omega$ | - | 25 | 50 | | |
| Fall time | t _f | | - | 12 | 24 | | |
| Drain-Source Body Diode Characterist | <u> </u> | | | <u>I</u> | <u> </u> | | |
| Continuous source-drain diode current | Is | T _C = 25 °C | _ | <u> </u> | 94.5 | | |
| Pulse diode forward current | I _{SM} | <u> </u> | _ | - | 300 | A | |
| Body diode voltage | V _{SD} | I _S = 5 A, V _{GS} = 0 V | - | 0.75 | 1.1 | V | |
| Body diode reverse recovery time | t _{rr} | .5 | _ | 67 | 134 | ns | |
| Body diode reverse recovery time | Q _{rr} | L = 10 A di/dt = 100 A/:: | _ | 88 | 176 | nC | |
| Reverse recovery fall time | t _a | $I_F = 10 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s,}$ $T_{.l} = 25 ^{\circ}\text{C}$ | _ | 28 | - | 110 | |
| , | + | .0 20 0 | | | - | ns | |
| Reverse recovery rise time | t _b | - | - | 38.8 | | | |

Notes

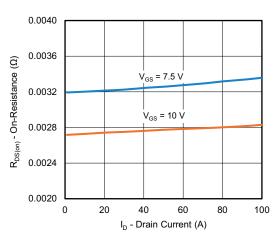
- a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

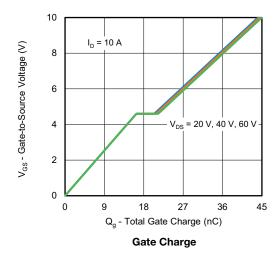


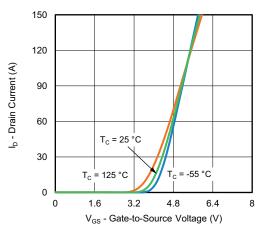


Output Characteristics

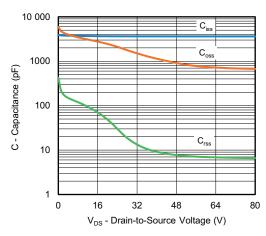


On-Resistance vs. Drain Current and Gate Voltage

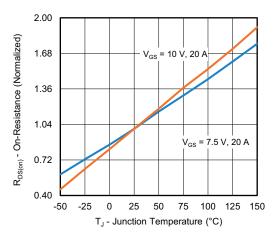




Transfer Characteristics

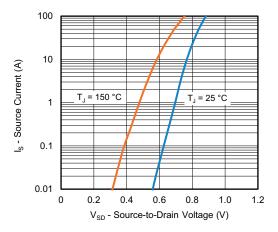


Capacitance

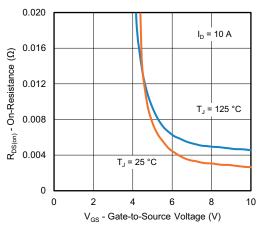


On-Resistance vs. Junction Temperature

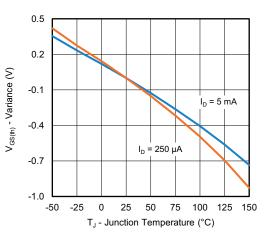




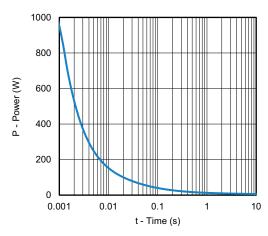
Source-Drain Diode Forward Voltage



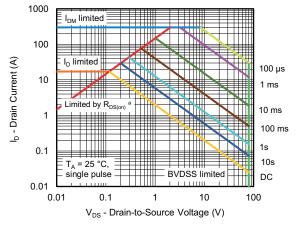
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power, Junction-to-Ambient

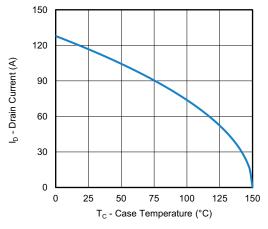


Safe Operating Area, Junction-to-Ambient

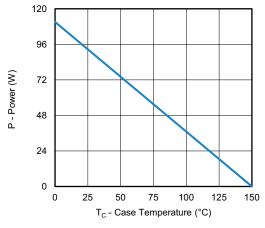
Note

a. V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

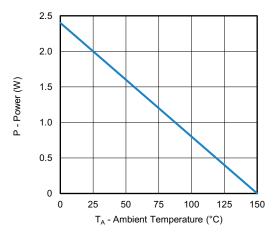




Current Derating a





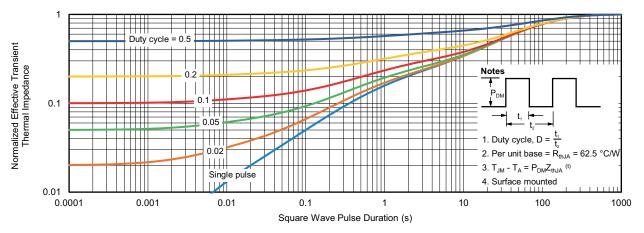


Power, Junction-to-Ambient

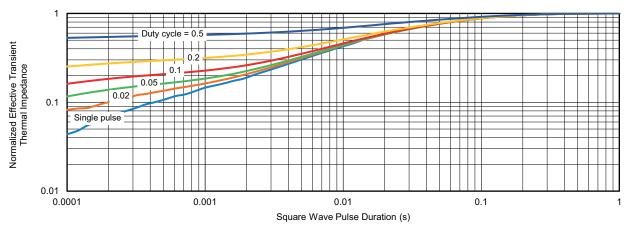
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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